



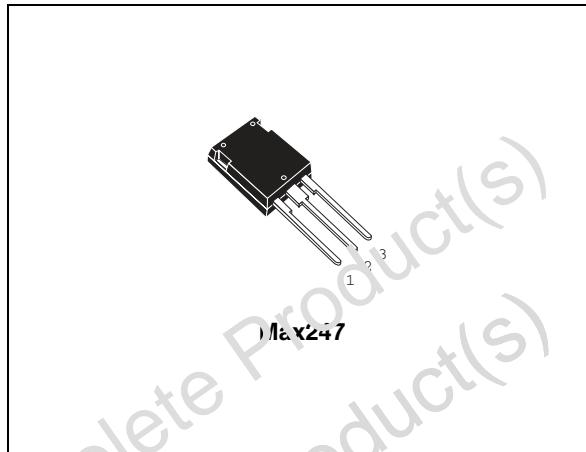
STY100NS20FD

N-channel 200V - 0.022Ω - 100A - Max247
MESH OVERLAY™ Power MOSFET

General features

Type	V _{DSS}	R _{DS(on)}	I _D
STY100NS20FD	200V	<0.024Ω	100A

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- ± 20V gate to source voltage rating
- Low intrinsic capacitance
- Fast body-drain diode: low t_{rr}, Q_{rr}



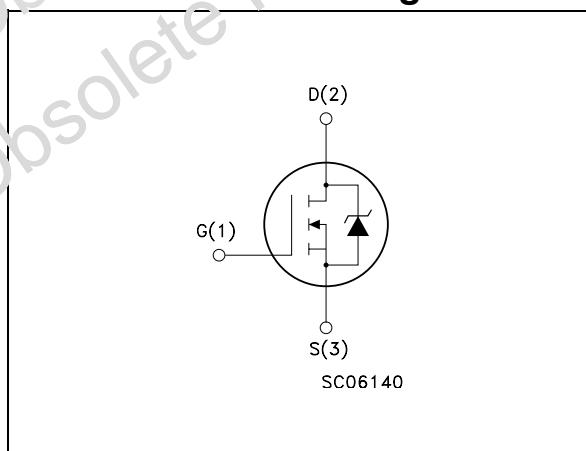
Description

Using the latest high voltage MESH OVERLAY™ process, STMicroelectronics has designed an advanced family of Power MOSFETs with outstanding performances. The new patented STrip layout coupled with the Company's proprietary edge termination structure, gives the lowest R_{DS(ON)} per area, exceptional avalanche and dv/dt capabilities and unrivaled gate charge and switching characteristics.

Applications

- Switching application

Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STY100NS20FD	Y100NS20FD	Max247	Tube

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1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	200	V
V_{DGR}	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	200	V
V_{GS}	Gate- source voltage	± 20	V
I_D	Drain current (continuos) at $T_C = 25^\circ\text{C}$	100	A
I_D	Drain current (continuos) at $T_C = 100^\circ\text{C}$	63	A
$I_{DM}^{(1)}$	Drain current (pulsed)	400	A
P_{TOT}	Total dissipation at $T_C = 25^\circ\text{C}$	450	W
	Derating factor	3.6	W/ $^\circ\text{C}$
$dv/dt^{(2)}$	Peak diode recovery voltage slope	25	V/ns
T_{stg}	Storage temperature	-65 to 150	$^\circ\text{C}$
T_j	Max. operating junction temperature	150	$^\circ\text{C}$

1. Pulse width limited by safe operating area

2. $I_{SD} \leq 100\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} = 80\%$ $V_{(BR)DS}$ **Table 2. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case Max	0.277	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-ambient Max	30	$^\circ\text{C/W}$
T_I	Maximum lead temperature for soldering purpose	300	$^\circ\text{C}$

Table 3. Avalanche data

Symbol	Parameter	Value	Unit
I_{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	110	A
E_{AS}	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$, $I_D = I_{AR}$, $V_{DD} = 50\text{ V}$)	750	mJ

2 Electrical characteristics

($T_{CASE}=25^\circ\text{C}$ unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0$	200			V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = \text{Max rating}$ $V_{DS} = \text{Max rating, } @125^\circ\text{C}$			10 100	μA μA
I_{GSS}	Gate body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 20\text{V}$			$\pm 10\text{nA}$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2	3	4	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10\text{V}, I_D = 50\text{A}$		0.022	0.024	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
g_{fs} (1)	Forward transconductance	$V_{DS} > I_{D(\text{on})} \times R_{DS(\text{on})\text{max}},$ $I_D < 50\text{A}$		30		s
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25\text{V}, f=1 \text{ MHz}, V_{GS}=0$		7900 1500 460		pF pF pF
Q_g Q_{gs} Q_{gd}	Total gate charge Gate source charge Gate-drain charge	$V_{DD} = 100\text{V}, I_D = 100\text{A},$ $V_{GS} = 10\text{V}$ (see Figure 13)		360 35 135		nC nC nC

(1) Pulsed: pulse duration=300 μs , duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test Condictions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time Rise time	$V_{DD} = 100V, I_D = 50A$ $R_G = 4.7\Omega V_{GS} = 10V$ (see Figure 12)		42 140		ns ns
$t_{r(V_{off})}$ t_f t_c	Off-voltage rise time Fall time Cross-over time	$V_{DD} = 100V, I_D = 100A,$ $R_G = 4.7\Omega V_{GS} = 10V$ (see Figure 12)		245 140 220		ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min	Typ.	Max	Unit
I_{SD}	Source-drain current				100	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				400	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 100A, V_{GS} = 0$			1.6	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}=100A, T_j=150^\circ C$ $dI/dt = 100A/\mu s$ $V_{DD}=160V$, (see Figure 17)		225 1.35 12		ns μC A

1. Pulse width limited by safe operating area
 2. Pulsed: pulse duration=300 μ s, duty cycle .5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

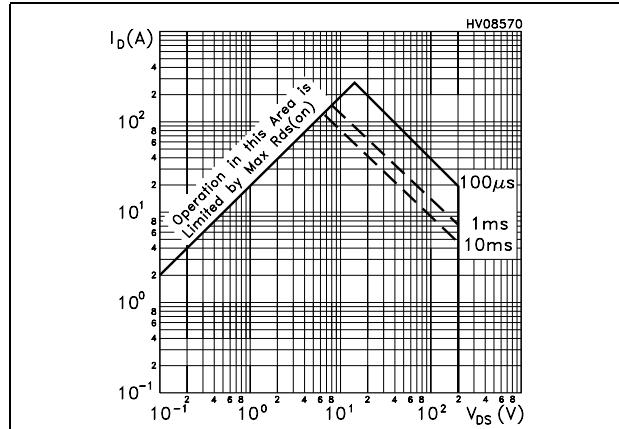


Figure 2. Thermal impedance

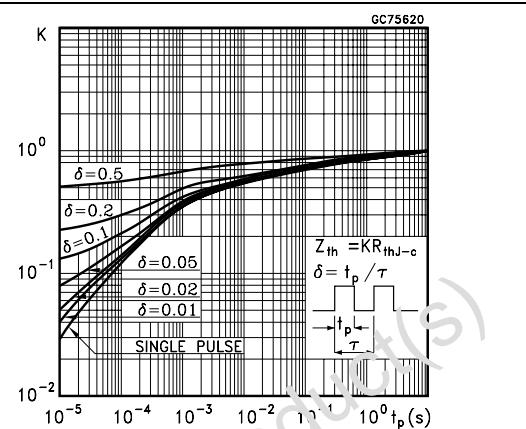


Figure 3. Output characteristics

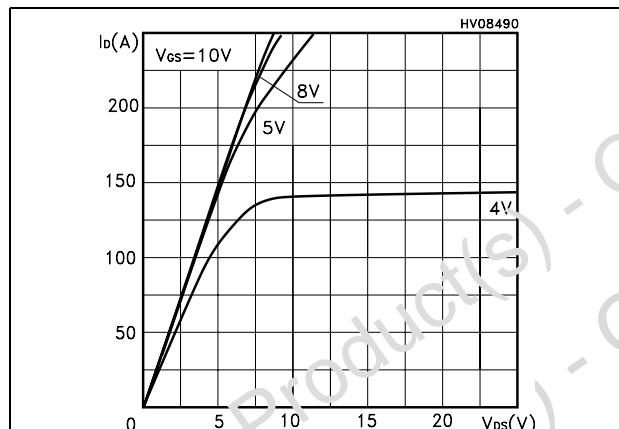


Figure 4. Transfer characteristics

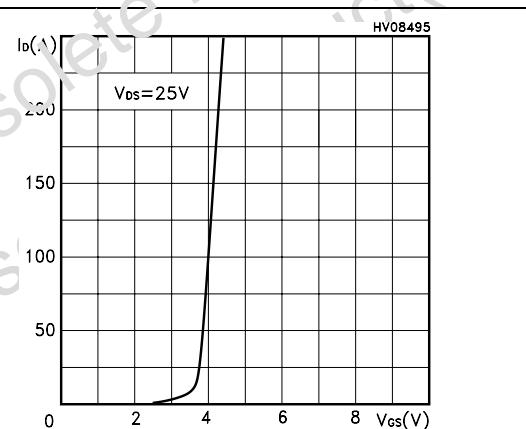


Figure 5. Transconductance

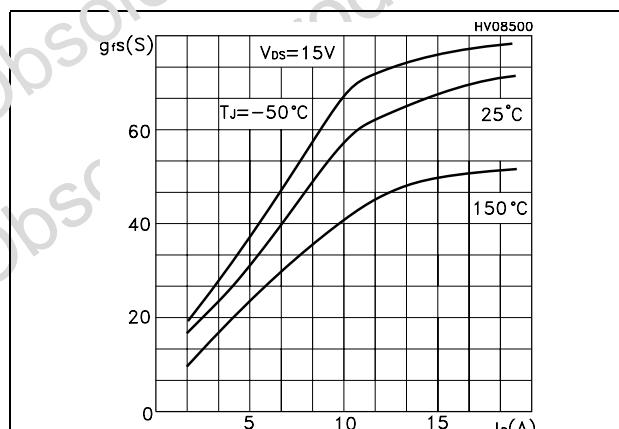


Figure 6. Static drain-source on resistance

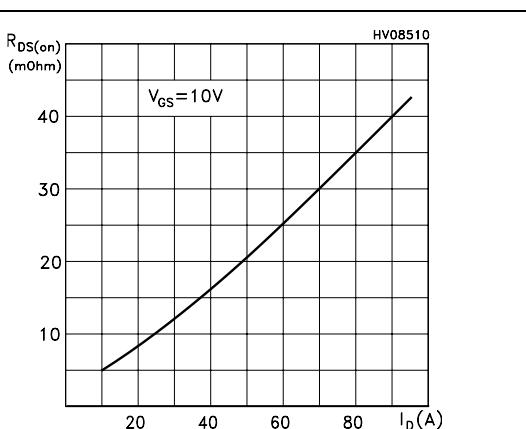
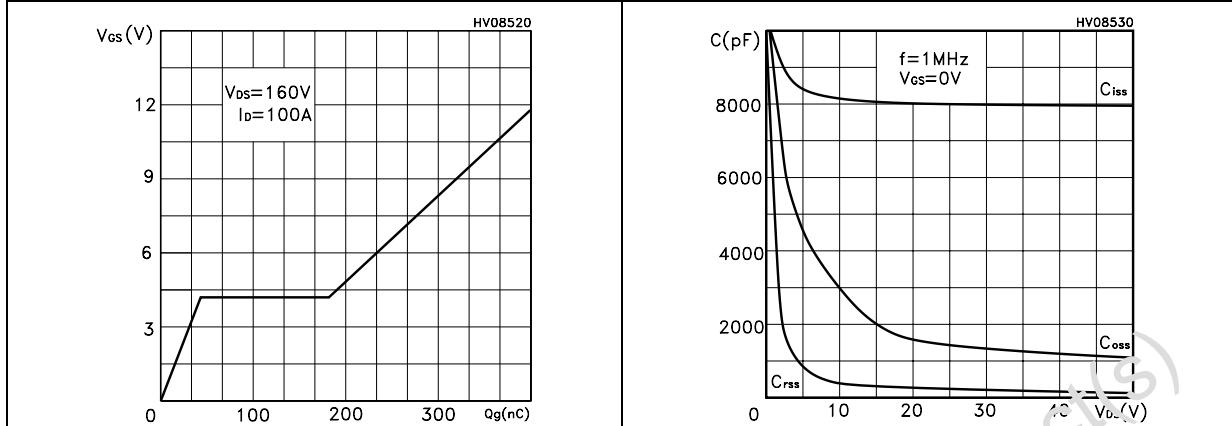
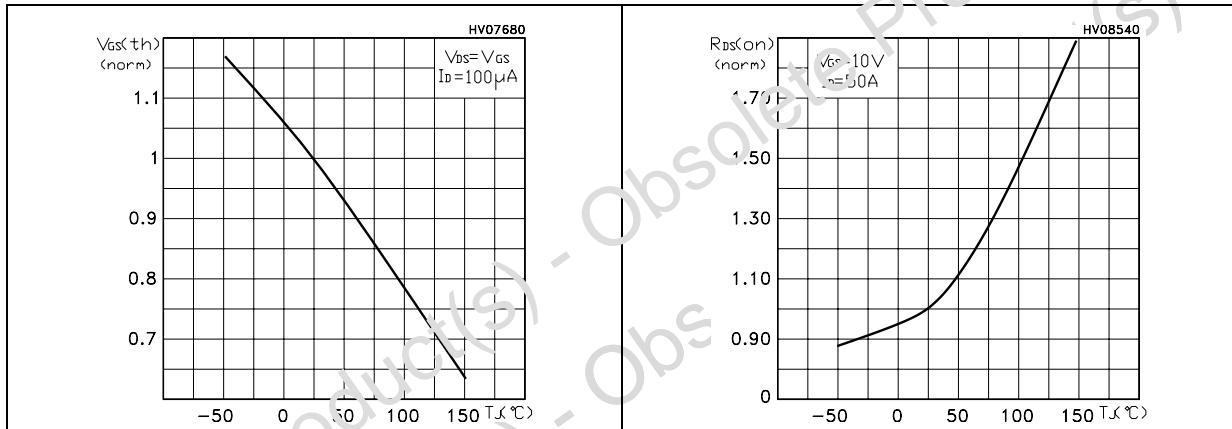
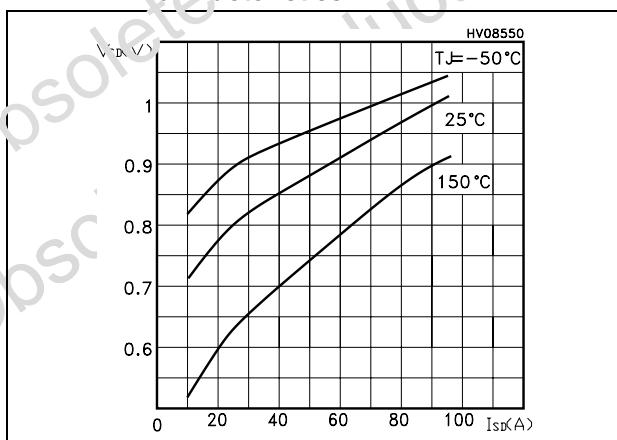


Figure 7. Gate charge vs gate-source voltage **Figure 8.** Capacitance variations**Figure 9.** Normalized gate threshold voltage vs temperature**Figure 10.** Normalized on resistance vs temperature**Figure 11.** Source-drain diode forward characteristics

3 Test circuit

Figure 12. Switching times test circuit for resistive load

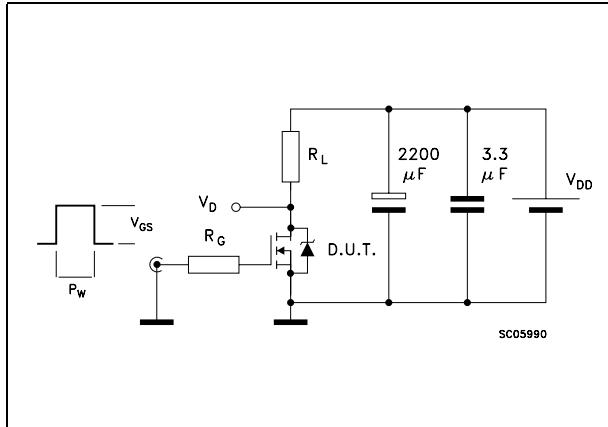


Figure 14. Test circuit for inductive load switching and diode recovery times

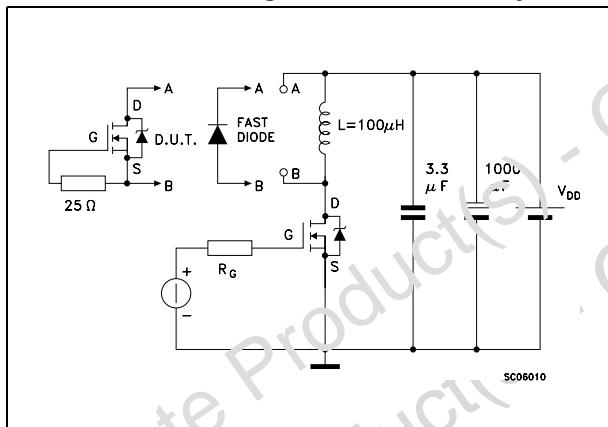


Figure 16. Unclamped inductive waveform

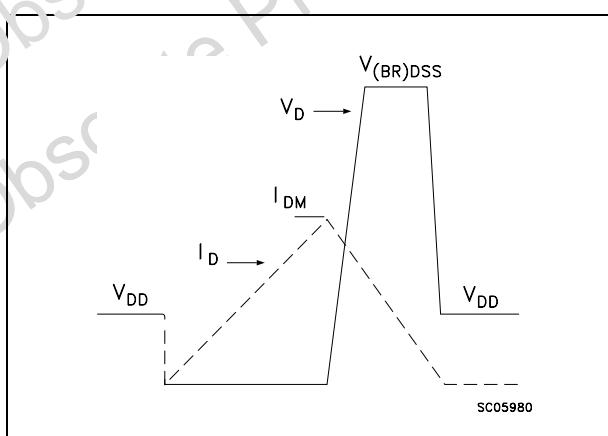


Figure 13. Gate charge test circuit

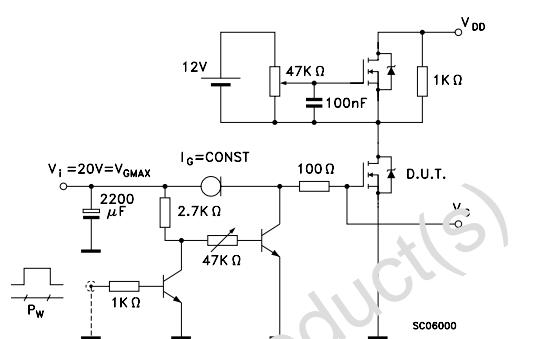


Figure 15. Unclamped inductive load test circuit

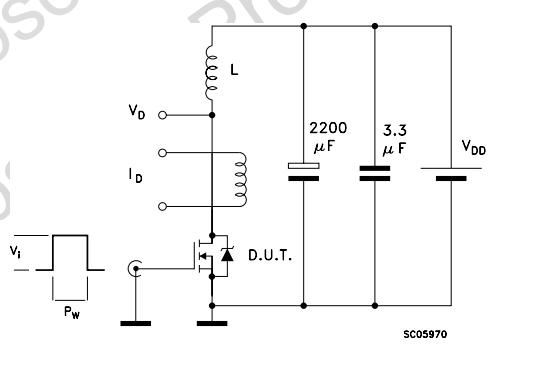
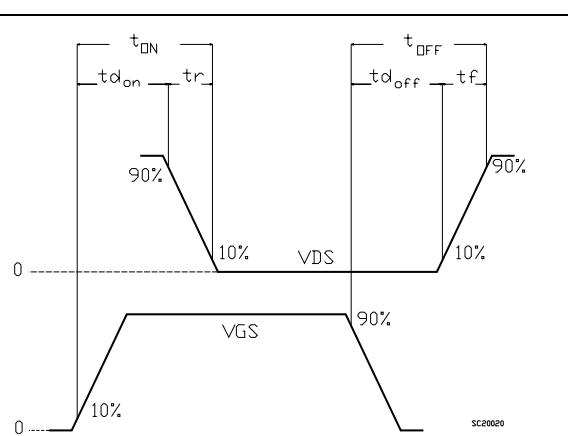


Figure 17. Switching time waveform

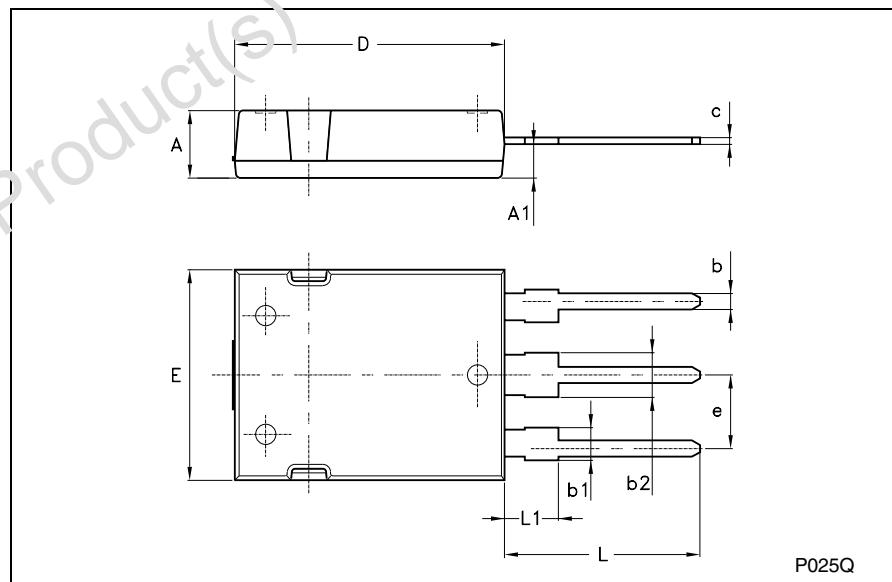


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at : www.st.com

Max247 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.70		5.30			
A1	2.20		2.60			
b	1.00		1.40			
b1	2.00		2.40			
b2	3.00		3.40			
c	0.40		0.80			
D	19.70		20.30			
e	5.35		5.55			
E	15.30		15.90			
L	14.20		15.20			
L1	3.70		4.30			



5 Revision history

Table 8. Revision history

Date	Revision	Changes
15-May-2006	3	New template

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